

PATENT APPLICATION

1AP20 Rec'd PCT/PTO 21 APR 2006
IN THE U.S. PATENT AND TRADEMARK OFFICE

April 21, 2006

Applicant(s) : Francesco FERRAILOLO
For : PROTECTIVE WIRE NET, A PROTECTIVE STRUCTURE
CONSTRUCTED WITH THE NET AND THE USE OF THE
PROTECTIVE WIRE NET FOR THE CONSTRUCTION OF A
PROTECTIVE STRUCTURE

Serial No. : Unknown Group: Unknown
Confirmation No.: Unknown
Filed : Unknown Examiner: Unknown
International Application No. : PCT/IT2003/000653
International Filing Date : October 22, 2003
Atty. Docket No.: 5405.P0027US

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

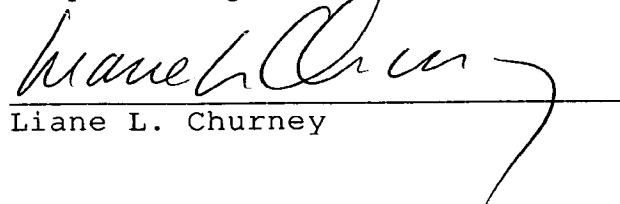
Sir:

In compliance with the provisions of Rules 1.97(b)(2) and 1.98, enclosed herewith is a copy of the International Search Report for the PCT application corresponding to the present application and Form PTO-1449. Copies of cited U.S. references are not submitted in accordance with 37 CFR 1.98(a).

The relevance of the enclosed references is explained on the enclosed International Search Report. Further comment at this point in time should not be necessary.

Further consideration is respectfully solicited.

Respectfully submitted,


Liane L. Churney

LLC/DJW/jas

Receipt date: 04/21/2006

10/576593 AU: 3725

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INFORMATION
DISCLOSURE
CITATION

Applicant: Francesco FERRAILOLO

Ser.No.: Unknown

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10/576593**APR 21 2006**

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA	US 5 524 875	06-11-1996	Thommen, Jr.
	AB	US 6 131 873	10-17-2000	Blazon et al
	AC	US 6 279 858 B1	08-28-2001	Eicher
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL				
	AM				
	AN				
	AO				
	AP				

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	International Search Report dated July 5, 2004 (4 pages)
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED
/Teresa Bonk/		07/01/2008

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.